

Page i

DIODES, MICROWAVE, SILICON, PIN, HIGH POWER, BASED ON TYPES ML4640 THRU ML4647 ESCC Detail Specification No. 5513/012

ISSUE 1 October 2002





ESCC Detail Specification

PAGE	ii
ISSUE	1

LEGAL DISCLAIMER AND COPYRIGHT

European Space Agency, Copyright © 2002. All rights reserved.

The European Space Agency disclaims any liability or responsibility, to any person or entity, with respect to any loss or damage caused, or allleged to be caused, directly or indirectly by the use and application of this ESCC publication.

This publication, without the prior permission of the European Space Ageny and provided that it is not used for a commercial purpose, may be:

- copied in whole in any medium without alteration or modification.
- copied in part, in any medium, provided that the ESCC document identification, comprising the ESCC symbol, document number and document issue, is removed.



european space agency agence spatiale européenne

Pages 1 to 30

DIODES, MICROWAVE, SILICON, PIN, HIGH POWER, BASED ON TYPES ML4640 THRU ML4647 ESA/SCC Detail Specification No. 5513/012



space components coordination group

		Approved by		
Issue/Rev.	Date	SCCG Chairman	ESA Director General or his Deputy	
Issue 1	May 1993	Tommers	1. lat	
		<i>y</i>		



PAGE 2

ISSUE 1

DOCUMENTATION CHANGE NOTICE

Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
		· ·		
:				
:		·		
		·		
:				



PAGE 3

ISSUE 1

TABLE OF CONTENTS

1.	GENERAL	Page 5
1.1	Scope	5
1.2	Type Variants	5
1.3	Maximum Ratings	5
1.4	Parameter Derating Information	5
1.5	Physical Dimensions	5
1.6	Functional Diagram	5
1.7	Handling Precautions	5
2.	APPLICABLE DOCUMENTS	5
3.	TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS	5
4.	REQUIREMENTS	19
4.1	General	19
4.2	Deviations from Generic Specification	19
4.2.1	Deviations from Special In-process Controls	19
4.2.2	Deviations from Final Production Tests	19
4.2.3	Deviations from Burn-in and Electrical Measurements	19
4.2.4	Deviations from Qualification Tests	19
4.2.5	Deviations from Lot Acceptance Tests	19
4.3	Mechanical and Environmental Requirements	20
4.3.1	Dimension Check	20
4.3.2	Weight	20
4.3.3	Terminal Strength	20
4.4	Materials and Finishes	21
4.4.1	Case	21
4.4.2	Lead Materials and Finish	21
4.5	Marking	21
4.5.1	General	21
4.5.2	Cathode Identification	22
4.5.3	The SCC Component Number	22
4.5.4	Traceability Information	22
4.6	Electrical Measurements	22
4.6.1	Electrical Measurements at Room Temperature	22
4.6.2	Electrical Measurements at High and Low Temperatures	22
4.6.3	Circuits for Electrical Measurements	22
4.7	Burn-in Tests	22
4.7.1	Parameter Drift Values	22
4.7.2	Conditions for High Temperature Reverse Bias Burn-in	22
4.7.3	Conditions for Power Burn-in	23
4.7.4	Electrical Circuits for High Temperature Reverse Bias and Power Burn-in	23
4.8	Environmental and Endurance Tests	28
4.8.1	Electrical Measurements on Completion of Environmental Tests	28
4.8.2	Electrical Measurements at Intermediate Points and on Completion of Endurance Tests	28 28
4.8.3	Conditions for Operating Life Tests	28 28
4.8.4	Electrical Circuits for Operating Life Tests	28 28
4.9	Total Dose Irradiation Testing	28 28
4.9.1	Application Bias Conditions	26 28
4.9.2 4.9.3	Electrical Measurements	28 28
4.9.3 4.10	Special Testing	28 28
7.10	Openial Testing	20



PAGE 4 ISSUE 1

TABLI	<u>≣S</u>	Page
1(a)	Type Variants	6
1(b)	Maximum Ratings	9
2	Electrical Measurements at Room Temperature - D.C. Parameters	24
	Electrical Measurements at Room Temperature - A.C. Parameters	24
3	Electrical Measurements at High and Low Temperatures	25
4	Parameter Drift Values	25
5(a)	Conditions for High Temperature Reverse Bias Burn-in	27
5(b)	Conditions for Power Burn-in	27
5(c)	Conditions for Operating Life Tests	27
6	Electrical Measurements at Intermediate Points and on Completion of Endurance Testing	29
7	Electrical Measurements During and on Completion of Irradiation Testing	30
FIGUE	RES	
1	Parameter Derating Information	10
2	Physical Dimensions	11
3	Functional Diagram	18
4	Circuits for Electrical Measurements	26
5(a)	Electrical Circuit for High Temperature Reverse Bias Burn-in	27
5(b)	Electrical Circuit for Power Burn-in and Operating Life Tests	27
6	Rice Conditions for Irradiation Testing	20

APPENDICES (Applicable to specific Manufacturers only)

None.



PAGE

5

ISSUE 1

1. GENERAL

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, test and inspection data for a Diode, Microwave, Silicon, PIN, High Power, based on Types ML4640 thru ML4647. It shall be read in conjunction with ESA/SCC Generic Specification No. 5010, the requirements of which are supplemented herein.

1.2 TYPE VARIANTS

Variants of the basic diodes specified herein, which are also covered by this specification are given in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the diodes specified herein, are as scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The derating information applicable to the diodes specified herein is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the diodes specified herein are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram, showing lead identification, of the diodes specified herein, is shown in Figure 3.

1.7 HANDLING PRECAUTIONS

These devices are susceptible to damage by electrostatic discharge. Therefore, suitable precautions shall be employed for protection during all phases of manufacture, testing, packaging, shipment and any handling.

These components are Categorised as Class 2 with a Minimum Critical Path Failure Voltage of 3600V.

2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

- (a) ESA/SCC Generic Specification No. 5010 for Discrete Microwave Semiconductor Components.
- (b) MIL-STD-750, Test Methods and Procedures for Semiconductor Devices.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply.



PAGE 6

ISSUE 1

TABLE 1(a) - TYPE VARIANTS

(1) VARIANT	(2) BASED ON	(3) FIGURE	(4) TOTAL CAPACITANCE C _T (pF)		(5) JUNCTION CAPACITANCE	(6) BODY-LID AND LEAD
	TYPE		MIN	MAX	C _J (pF) (Typical)	MATERIAL AND FINISH
01	ML4640 - 30	2(a)	0.25	0.35	0.1	A7-D2
02	ML4640 - 31	2(b)	0.25	0.35	0.1	A7-D2
03	ML4640 - 32	2(c)	0.36	0.46	0.1	A7-D2
04	ML4640 - 34	2(d)	0.45	0.55	0.1	A7-D2
05	ML4640 - 36	2(e)	0.25	0.35	0.1	A7-D2
06	ML4640 - 43	2(f)	0.85	0.95	0.1	A7-D2
07	ML4640 - 56	2(g)	0.58	0.68	0.1	A7-D2
08	ML4640 - 91	2(h)	0.36	0.46	0.1	A7-D2
09	ML4640 - 92	2(i)	0.36	0.46	0.1	A7-D2
10	ML4640 - 101	2(j)	0.55	0.65	0.1	A7-D2
11	ML4640 - 103	2(k)	0.36	0.46	0.1	A7-D2
12	ML4640 - 255	2(I)	0.35	0.45	0.1	A 7
13	ML4640 - 186	2(m)	0.20	0.30	0.1	D2
14	ML4641 - 30	2(a)	0.35	0.45	0.2	A7-D2
15	ML4641 - 31	2(b)	0.35	0.45	0.2	A7-D2
16	ML4641 - 32	2(c)	0.46	0.56	0.2	A7-D2
17	ML4641 - 34	2(d)	0.55	0.65	0.2	A7-D2
18	ML4641 - 36	2(e)	0.35	0.45	0.2	A7-D2
19	ML4641 - 43	2(f)	0.95	1.05	0.2	A7-D2
20	ML4641 - 56	2(g)	0.68	0.78	0.2	A7-D2
21	ML4641 - 91	2(h)	0.46	0.56	0.2	A7-D2
22	ML4641 - 92	2(i)	0.46	0.56	0.2	A7-D2
23	ML4641 - 101	2(j)	0.65	0.75	0.2	A7-D2
24	ML4641 - 103	2(k)	0.46	0.56	0.2	A7-D2
25	ML4641 - 255	2(I)	0.45	0.55	0.2	A7
26	ML4641 - 186	2(m)	0.30	0.40	0.2	D2
27	ML4642 - 30	2(a)	0.45	0.60	0.3	A7-D2
28	ML4642 - 31	2(b)	0.45	0.60	0.3	A7-D2
29	ML4642 - 32	2(c)	0.56	0.71	0.3	A7-D2
30	ML4642 - 34	2(d)	0.65	0.80	0.3	A7-D2
31	ML4642 - 36	2(e)	0.45	0.60	0.3	A7-D2
32	ML4642 - 43	2(f)	1.05	1.20	0.3	A7-D2
33	ML4642 - 56	2(g)	0.75	0.90	0.3	A7-D2
34	ML4642 - 91	2(h)	0.56	0.71	0.3	A7-D2
35	ML4642 - 92	2(i)	0.56	0.71	0.3	A7-D2
36	ML4642 - 101	2(j)	0.75	0.90	0.3	A7-D2



PAGE 7

ISSUE 1

TABLE 1(a) - TYPE VARIANTS (CONT'D)

(1) VARIANT	BASED ON	(3) FIGURE		TOTAL CAPACITANCE C _T (pF)		(6) BODY-LID AND LEAD
	TYPE		MIN	MAX	С _Ј (pF) (Typical)	MATERIAL AND FINISH
37	ML4642 - 103	2(k)	0.56	0.71	0.3	A7-D2
38	ML4642 - 255	2(l)	0.55	0.70	0.3	A 7
39	ML4643 - 30	2(a)	0.60	0.80	0.5	A7-D2
40	ML4643 - 31	2(b)	0.60	0.80	0.5	A7-D2
41	ML4643 - 32	2(c)	0.71	0.91	0.5	A7-D2
42	ML4643 - 34	2(d)	0.80	1.00	0.5	A7-D2
43	ML4643 - 36	2(e)	0.60	0.80	0.5	A7-D2
44	ML4643 - 43	2(f)	1.20	1.40	0.5	A7-D2
45	ML4643 - 56	2(g)	0.93	1.13	0.5	A7-D2
46	ML4643 - 91	2(h)	0.71	0.91	0.5	A7-D2
47	ML4643 - 92	2(i)	0.71	0.91	0.5	A7-D2
48	ML4643 - 101	2(j)	0.90	1.10	0.5	A7-D2
49	ML4643 - 103	2(k)	0.71	0.91	0.5	A7-D2
50	ML4643 - 255	2(1)	0.70	0.90	0.5	A 7
51	ML4644 - 30	2(a)	0.25	0.35	0.1	A7-D2
52	ML4644 - 31	2(b)	0.25	0.35	0.1	A7-D2
53	ML4644 - 32	2(c)	0.36	0.46	0.1	A7-D2
54	ML4644 - 34	2(d)	0.45	0.55	0.1	A7-D2
55	ML4644 - 36	2(e)	0.25	0.35	0.1	A7-D2
56	ML4644 - 43	2(f)	0.85	0.95	0.1	A7-D2
57	ML4644 - 56	2(g)	0.58	0.68	0.1	A7-D2
58	ML4644 - 91	2(h)	0.36	0.46	0.1	A7-D2
59	ML4644 - 92	2(i)	0.36	0.46	0.1	A7-D2
60	ML4644 - 101	2(j)	0.55	0.65	0.1	A7-D2
61	ML4644 - 103	2(k)	0.36	0.46	0.1	A7-D2
62	ML4644 - 255	2(1)	0.35	0.45	0.1	A 7
63	ML4644 - 186	2(m)	0.20	0.30	0.1	D2
64	ML4645 - 30	2(a)	0.35	0.45	0.2	A7-D2
65	ML4645 - 31	2(b)	0.35	0.45	0.2	A7-D2
66	ML4645 - 32	2(c)	0.46	0.56	0.2	A7-D2
67	ML4645 - 34	2(d)	0.55	0.65	0.2	A7-D2
68	ML4645 - 36	2(e)	0.35	0.45	0.2	A7-D2
69	ML4645 - 43	2(f)	0.95	1.05	0.2	A7-D2
70	ML4645 - 56	2(g)	0.68	0.78	0.2	A7-D2
71	ML4645 - 91	2(h)	0.46	0.56	0.2	A7-D2
72	ML4645 - 92	2(i)	0.46	0.56	0.2	A7-D2



PAGE 8

ISSUE 1

TABLE 1(a) - TYPE VARIANTS (CONT'D)

(1) VARIANT	(2) BASED ON	(3) FIGURE	TOTAL CAP. C _T ((5) JUNCTION CAPACITANCE	(6) BODY-LID AND LEAD
	TYPE		MIN	MAX	C _J (pF) (Typical)	MATERIAL AND FINISH
73	ML4645 - 101	2(j)	0.65	0.75	0.2	A7-D2
74	ML4645 - 103	2(k)	0.46	0.56	0.2	A7-D2
75	ML4645 - 255	2(1)	0.45	0.55	0.2	A7
76	ML4646 - 30	2(a)	0.45	0.60	0.3	A7-D2
77	ML4646 - 31	2(b)	0.45	0.60	0.3	A7-D2
78	ML4646 - 32	2(c)	0.56	0.71	0.3	A7-D2
79	ML4646 - 34	2(d)	0.65	0.80	0.3	A7-D2
80	ML4646 - 36	2(e)	0.45	0.60	0.3	A7-D2
81	ML4646 - 43	2(f)	1.05	1.20	0.3	A7-D2
82	ML4646 - 56	2(g)	0.75	0.90	0.3	A7-D2
83	ML4646 - 91	2(h)	0.56	0.71	0.3	A7-D2
84	ML4646 - 92	2(i)	0.56	0.71	0.3	A7-D2
85	ML4646 - 101	2(j)	0.75	0.90	0.3	A7-D2
86	ML4646 - 103	2(k)	0.56	0.71	0.3	A7-D2
87	ML4646 - 255	2(l)	0.55	0.70	0.3	A 7
88	ML4647 - 34	2(d)	0.80	1.00	0.5	A7-D2
89	ML4647 - 43	2(f)	1.20	1.40	0.5	A7-D2
90	ML4647 - 56	2(g)	0.93	1.13	0.5	A7-D2
91	ML4647 - 101	2(j)	0.90	1.10	0.5	A7-D2



PAGE 9

ISSUE 1

TABLE 1(b) - MAXIMUM RATINGS

No.	CHARACTERISTIC	SYMBOL	MAXIMUM RATINGS	UNIT	REMARKS
1	D.C. Reverse Voltage Variants 01 to 50 Variants 51 to 91	VR	- 300 400	· V	Note 1
2	D.C. Forward Current (Continuous) Variants 01 to 50 Variants 51 to 91	ļĖ	200 250	mA	Note 2
3	R.F. Power Dissipation Variants 01 to 12 Variant 13 Variants 14 to 25 Variant 26 Variants 27 to 38 Variants 39 to 50 Variants 51 to 62 Variant 63 Variants 64 to 75 Variants 76 to 87 Variants 88 to 91	P _{tot}	4.0 0.6 5.0 0.8 5.0 6.0 5.0 0.8 5.0 6.0 8.0	W	Note 1
4	Operating Temperature Range	T _{op}	-65 to +150	°C	T _{case}
5	Storage Temperature Range	T _{stg}	-65 to +150	°C	
6	Soldering Temperature	T _{sol}	+ 230	°C	Note 3

NOTES

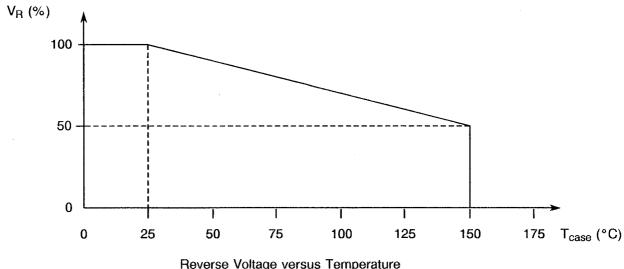
- 1. At $T_{case} = +25$ °C. For derating at $T_{case} > +25$ °C, see Figure 1.
- 2. At T_{case} = +100°C. For derating at T_{case} > +100°C, see Figure 1.
- 3. Duration 5 seconds maximum (at a distance of not less than 1.5mm from the body for Variants 13, 26 and 63) and the same termination shall not be resoldered until 3 minutes have elapsed.



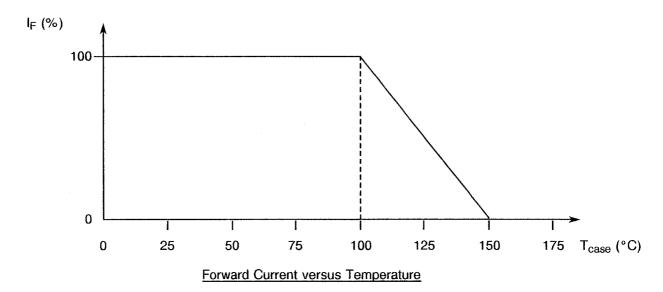
PAGE 10

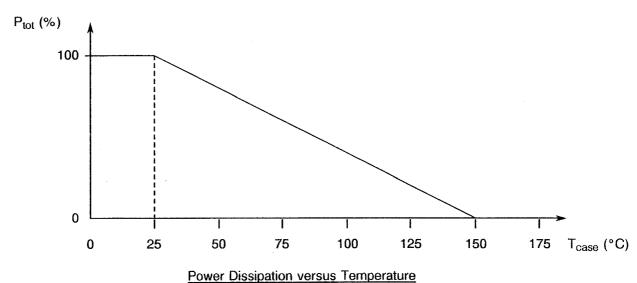
ISSUE

FIGURE 1 - PARAMETER DERATING INFORMATION



Reverse Voltage versus Temperature





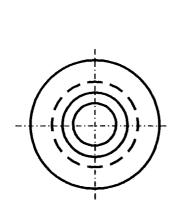


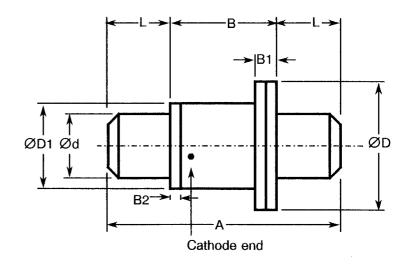
PAGE 11

ISSUE 1

FIGURE 2 - PHYSICAL DIMENSIONS

FIGURE 2(a) - VARIANTS 01, 14, 27, 39, 51, 64, 76





SYMBOL	MILLIMETRES		
STWIDOL	MIN	MAX	
Α	5.20	5.72	
В	2.16	2.46	
B1	0.41	0.61	
B2	0.15	0.25	
Ød	1.52	1.63	
ØD	3.00	3.23	
ØD1	1.95	2.11	
L	1.52	1.63	

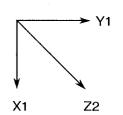
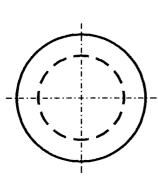
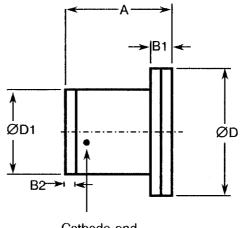


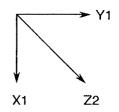
FIGURE 2(b) - VARIANTS 02, 15, 28, 40, 52, 65, 77



	Ĩ			
SYMBOL	MILLIM	ETRES		
STIVIBUL	MIN	MAX		
Α	2.16	2.46		
B1	0.41	0.61		
B2	0.15	0.25		
ØD	3.00	3.23		
ØD1	1.95	2.11		



Cathode end



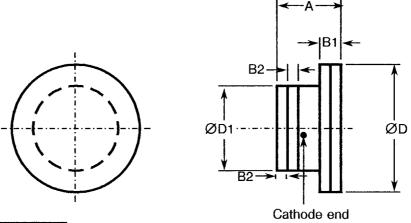


PAGE 12

ISSUE 1

FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(c) - VARIANTS 03, 16, 29, 41, 53, 66, 78



SYMBOL	MILLIM	MILLIMETRES		
STIVIDUL	MIN	MAX		
Α	1.37	1.68		
B1	0.41	0.61		
B2	0.15	0.20		
ØD	3.00	3.23		
ØD1	1.95	2.11		

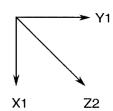
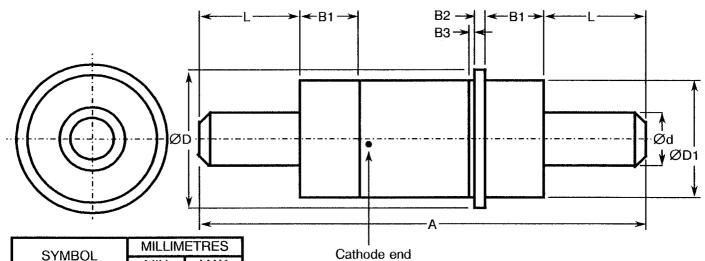
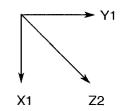


FIGURE 2(d) - VARIANTS 04, 17, 30, 42, 54, 67, 79, 88



SYMBOL	MILLIMETRES	
3 TIVIBOL	MIN	MAX
Α	19.45	20.12
B1	2.54	-
B2	0.53	0.83
B3	0.19	0.41
Ød	2.33	2.44
ØD	-	6.10
ØD1	5.20	5.46
L	4.57	4.83



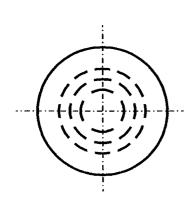


PAGE 13

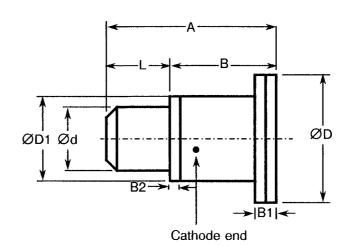
ISSUE 1

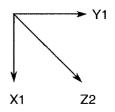
FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(e) - VARIANTS 05, 18, 31, 43, 55, 68, 80



SYMBOL	MILLIMETRES	
STWIBOL	MIN	MAX
Α	3.60	4.18
В	2.16	2.46
B1	0.41	0.61
B2	0.15	0.25
Ød	1.52	1.63
ØD	3.00	3.23
ØD1	1.95	2.11
L	1.52	1.63





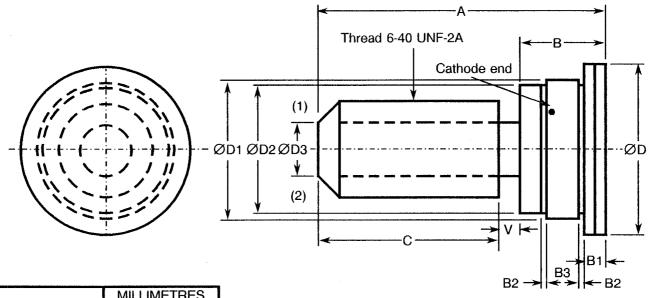


PAGE 14

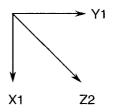
ISSUE 1

FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(f) - VARIANTS 06, 19, 32, 44, 56, 69, 81, 89



SYMBOL	MILLIMETRES	
STIVIDOL	MIN	MAX
Α	11.18	11.68
В	3.02	3.66
B1	0.64	0.89
B2	0.18	0.23
B3	1.17	1.27
С	6.50	7.90
ØD	6.48	6.73
ØD1	5.20	5.50
ØD2	4.80	5.20
ØD3	2.00	2.70
V	0.76	1.02



NOTES

- 1. Spline socket to fit S-072 Bristol spline key 1.78mm deep.
- 2. 0.51mm x 45°.

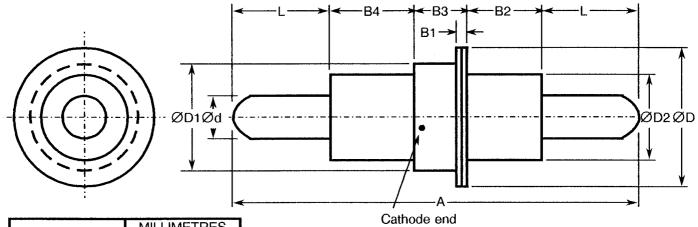


PAGE 15

ISSUE 1

FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(g) - VARIANTS 07, 20, 33, 45, 57, 70, 82, 90



SYMBOL	MILLIMETRES	
STWIDGE	MIN	MAX
Α	19.46	20.12
B1	-	0.76
B2	3.00	3.60
B3	2.41	2.67
B4	3.68	3.94
Ød	2.33	2.39
ØD	-	6.10
ØD1	4.72	4.83
ØD2	3.81	4.19
L	4.57	4.83

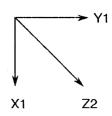
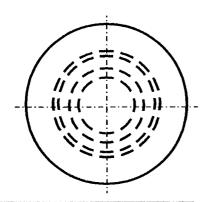
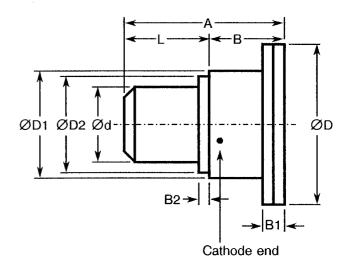
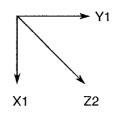


FIGURE 2(h) - VARIANTS 08, 21, 34, 46, 58, 71, 83



SYMBOL	MILLIMETRES	
STIVIDOL	MIN	MAX
Α	2.92	3.28
В	1.40	1.65
B1	0.41	0.61
B2	0.15	0.20
Ød	1.52	1.63
ØD	3.00	3.23
ØD1	1.95	2.11
ØD2	1.85	2.03
L	1.52	1.63





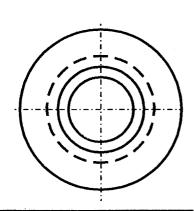


PAGE 16

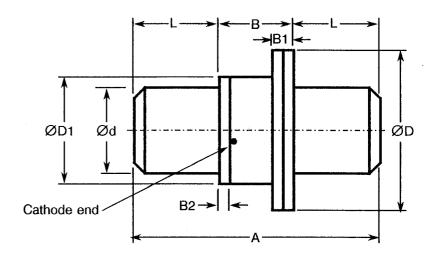
ISSUE 1

FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(i) - VARIANTS 09, 22, 35, 47, 59, 72, 84



SYMBOL	MILLIMETRES	
STIVIDOL	MIN	MAX
Α	4.42	4.93
В	1.40	1.65
B1	0.41	0.61
B2	0.15	0.20
Ød	1.52	1.63
ØD	3.00	3.23
ØD1	1.95	2.11
L	1.52	1.63



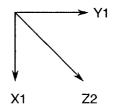
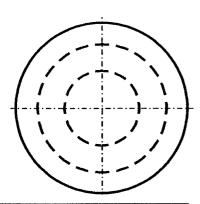
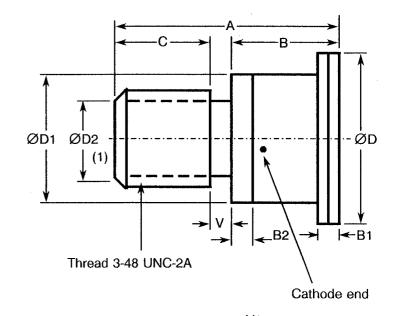


FIGURE 2(j) - VARIANTS 10, 23, 36, 48, 60, 73, 85, 91



SYMBOL	MILLIMETRES	
STIVIBOL	MIN	MAX
Α	5.34	5.74
В	2.52	2.72
B1	0.61	0.81
B2	0.65	0.85
С	1.68	2.58
ØD	4.03	4.09
ØD1	3.05	3.25
ØD2	1.60	2.00
V	0.64	0.94





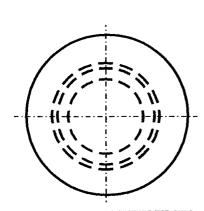


PAGE 17

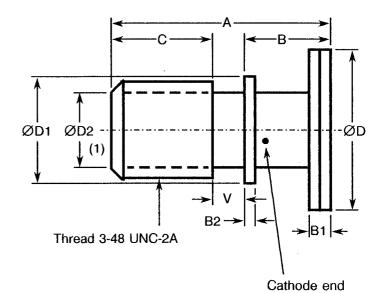
ISSUE 1

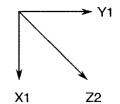
FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(k) - VARIANTS 11, 24, 37, 49, 61, 74, 86



SYMBOL	MILLIMETRES	
STIVIBOL	MIN	MAX
Α	4.71	5.30
В	1.47	1.80
B1	0.41	0.61
B2	0.20	0.30
C	1.97	3.19
ØD	3.00	3.23
ØD1	2.49	2.59
ØD2	1.60	2.00
V	0.64	0.94

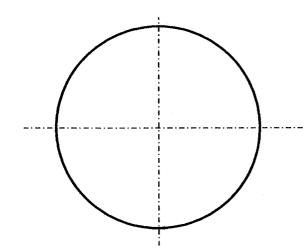




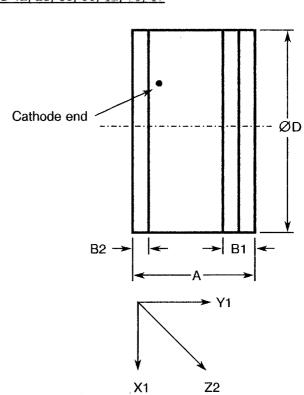
NOTES

1. 6 spline socket, 1.39mm deep.

FIGURE 2(I) - VARIANTS 12, 25, 38, 50, 62, 75, 87



SYMBOL	MILLIN	MILLIMETRES	
	MIN	MAX	
Α	1.14	1.40	
B1	0.23	0.33	
B2	0.15	0.20	
ØD	1.90	2.16	



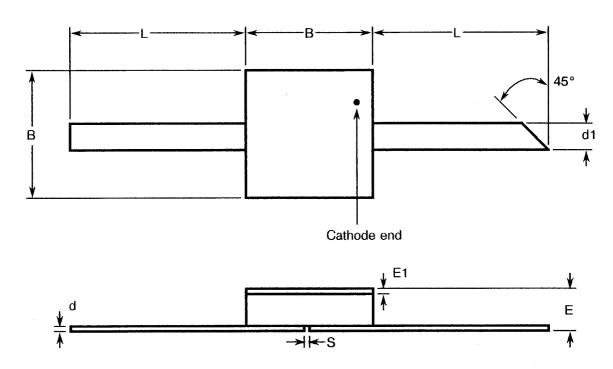


PAGE 18

ISSUE 1

FIGURE 2 - PHYSICAL DIMENSIONS (CONTINUED)

FIGURE 2(m) - VARIANTS 13, 26, 63



SYMBOL	MILLIMETRES	
STWIDOL	MIN	MAX
В	2.39	2.62
d	0.07	0.15
d1	0.48	0.56
Ε	0.79	1.12
E1	0.10	0.18
L	3.30	5.84
S	0.10	-

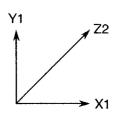
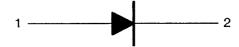


FIGURE 3 - FUNCTIONAL DIAGRAM



- 1. Anode
- 2. Cathode

NOTES

1. The cathode end shall be marked with a black dot or band. The marking will not be on the cathode connection but adjacent to it.



PAGE 19

ISSUE 1

4. REQUIREMENTS

4.1 GENERAL

The complete requirements for procurement of the diodes specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 5010 for Discrete Microwave Semiconductor Components. Deviations from the Generic Specification applicable to this specification only, are listed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

4.2.1 <u>Deviations from Special In-process Controls</u>

- (a) Para. 5.2.2, Total Dose Irradiation Testing: Shall be performed during qualification and extension of qualification.
- (b) Para. 5.2.2, Total Dose Irradiation Testing: Shall be performed during procurement on a lot acceptance basis at the total dose irradiation level specified in the purchase order.
- (c) Para. 5.3, Wafer Lot Acceptance: Shall be performed as an S.E.M. Inspection only.

4.2.2 Deviations from Final Production Tests (Chart II)

- (a) Para. 6.2, Pre-burn-in: Shall be performed in accordance with Para. 9.21(a).
- (b) Para. 9.14, Vibration, Variable Frequency: Shall not be performed.

4.2.3 Deviations from Burn-in and Electrical Measurements (Chart III)

(a) Para. 7.1.1(a), High Temperature Reverse Bias Burn-in: Shall be performed at 50% of rated V_B.

4.2.4 Deviations from Qualification Tests (Chart IV)

(a) Para. 9.23, Special Testing: Shall not be performed.

4.2.5 Deviations from Lot Acceptance Tests (Chart V)

(a) Para. 9.23, Special Testing: Shall not be performed.



PAGE 20

ISSUE

4.3 MECHANICAL AND ENVIRONMENTAL REQUIREMENTS

4.3.1 <u>Dimension Check</u>

The dimensions of the diodes specified herein shall be checked. They shall conform to those shown in Figure 2.

4.3.2 Weight

The maximum weight of the diodes specified herein shall be:

Variant No.	Weight (g)
01, 14, 27, 39, 51, 64, 76	0.12
02, 15, 28, 40, 52, 65, 77	0.06
03, 16, 29, 41, 53, 66, 78	0.08
04, 17, 30, 42, 54, 67, 79, 88	2.14
05, 18, 31, 43, 55, 68, 80	0.10
06, 19, 32, 44, 56, 69, 81, 89	1.10

Variant No.	Weight (g)
07, 20, 33, 45, 57, 70, 82, 90	1.80
08, 21, 34, 46, 58, 71, 83	0.11
09, 22, 35, 47, 59, 72, 84	0.13
10, 23, 36, 48, 60, 73, 85, 91	0.24
11, 24, 37, 49, 61, 74, 86	0.14
12, 25, 38, 50, 62, 75, 87	0.08
13, 26, 63	0.06

4.3.3 <u>Terminal Strength</u>

The requirements for terminal strength testing are specified in Section 9 of ESA/SCC Generic Specification No. 5010. The test conditions shall be as follows:-

(a) Condition: 'A' (Tension)

Variants 13, 26 and 63:

Force: 5.1N.

- Duration: 5 seconds.

(b) Condition: 'D2' (Stud Torque)

Variants 06, 19, 32, 44, 56, 69, 81 and 89:

Torque: 70mNm.

Duration: 5 seconds.

Variants 10, 11, 23, 24, 36, 37, 48, 49, 60, 61, 73, 74, 85, 86 and 91:

Torque: 56mNm.

- Duration: 5 seconds.



PAGE 21

ISSUE 1

(c) Condition: Compression

Variants 01, 02, 03, 04, 05, 06, 07, 08, 09, 10, 11, 12, 14, 15, 16, 17, 18, 19, 20, 21, 22, 23, 24, 25, 27, 28, 29, 30, 31, 32, 33, 34, 35, 36, 37, 38, 39, 40, 41, 42, 43, 44, 45, 46, 47, 48, 49, 50, 51, 52, 53, 54, 55, 56, 57, 58, 59, 60, 61, 62, 64, 65, 66, 67, 68, 69, 70, 71, 72, 73, 74, 75, 76, 77, 78, 79, 80, 81, 82, 83, 84, 85, 86, 87, 88, 89, 90 and 91:

Force: 50N.

Duration: 5 seconds.

The compression test shall be performed by applying the specified force to the end-cap by means of a suitable weight applied for the specified time. On completion of the test, a visual examination shall be performed to check for damage to the end-cap or the ceramic body.

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the diodes specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material shall not guarantee acceptance of the finished product.

4.4.1 Case

The case shall be hermetically sealed and have a ceramic body. The lid shall be welded or preform soldered.

4.4.2 Lead Materials and Finish

- (a) For Variants 01, 02, 03, 04, 05, 06, 07, 08, 09, 10, 11, 14, 15, 16, 17, 18, 19, 20, 21, 22, 23, 24, 27, 28, 29, 30, 31, 32, 33, 34, 35, 36, 37, 39, 40, 41, 42, 43, 44, 45, 46, 47, 48, 49, 51, 52, 53, 54, 55, 56, 57, 58, 59, 60, 61, 64, 65, 66, 67, 68, 69, 70, 71, 72, 73, 74, 76, 77, 78, 79, 80, 81, 82, 83, 84, 85, 86, 88, 89, 90 and 91, the body material shall be Type 'A' with Type '7' finish and the lid material shall be Type 'D' with Type '2' finish, in accordance with the requirements of ESA/SCC Basic Specification No. 23500.
- (b) For Variants 12, 25, 38, 50, 62, 75 and 87, the lead material shall be Type 'A' with Type '7' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.
- (c) For Variants 13, 26 and 63, the lead material shall be Type 'D' with Type '2' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.5 MARKING

4.5.1 General

The marking of components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precedence, shall be as follows:-

- (a) Cathode Identification.
- (b) The SCC Component Number.
- (c) Traceability Information.



PAGE 22

ISSUE

EE4004004DE

4.5.2 Cathode Identification

Cathode identification shall be as shown in Figures 2 and 3 of this specification.

4.5.3 The SCC Component Number

Each component shall bear the SCC Component Number which shall be constituted and marked as follows:

	<u> </u>
Detail Specification Number	
Type Variant (see Table 1(a))	
Testing Level (B or C, as applicable)	
Total Dose Irradiation Level (if applicable)	

The Total Dose Irradiation Level designation shall be added for those devices for which a sample has been successfully tested to the level in question. For these devices, a code letter shall be added in accordance with the requirements of ESA/SCC Basic Specification No. 22900.

4.5.4 Traceability Information

Each component shall be marked in respect of traceability information as defined in ESA/SCC Basic Specification No. 21700.

4.6 <u>ELECTRICAL MEASUREMENTS</u>

4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.6.2 <u>Electrical Measurements at High and Low Temperatures</u>

The parameters to be measured at high and low temperatures are scheduled in Table 3. Unless otherwise specified, the measurements shall be performed at +150(+0-3) °C.

4.6.3 Circuits for Electrical Measurements

Circuits for use in performing electrical measurements listed in Table 2 of this specification are shown in Figure 4.

4.7 BURN-IN TESTS

Burn-in shall be Category 3 of Chart III(a).

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22±3 °C. The parameter drift values (Δ) applicable to the scheduled parameters shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

4.7.2 <u>Conditions for High Temperature Reverse Bias Burn-in</u>

The requirements for the high temperature reverse bias burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 5010. The conditions for high temperature reverse bias burn-in shall be as specified in Table 5(a) of this specification.



PAGE 23

ISSUE 1

4.7.3 Conditions for Power Burn-in

The requirements for power burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 5010. The conditions for power burn-in shall be as specified in Table 5(b) of this specification.

4.7.4 Electrical Circuits for High Temperature Reverse Bias and Power Burn-in

Circuits for use in performing the H.T.R.B and power burn-in tests are shown in Figures 5(a) and 5(b) of this specification.



PAGE 24 ISSUE 1

TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - D.C. PARAMETERS

No	CHADACTEDISTICS	CHARACTERISTICS SYMBOL MIL-STD-750		TEST CONDITIONS	LIMITS		UNIT
No.	CHARACTERISTICS	STIVIBUL	TEST METHOD TEST GONDITIONS		MIN.	MAX.	UNIT
1	Reverse Current 1	I _{R1}	4016	Variants 01 to 50: $V_R = -300V$ Variants 51 to 91: $V_R = -400V$	-	10	μА
2	Reverse Current 2	I _{R2}	4016	Variants 01 to 50: $V_R = -150V$ Variants 51 to 91: $V_R = -200V$	-	100	nA
3	Forward Voltage	V _F	4011	I _F = 100mA	4	1.0	٧
4	Thermal Resistance	R _{TH(J-C)}	3101	I _F = 1.0A Note 1 Variants 01 to 12 Variant 13 Variants 14 to 25 Variant 26 Variants 27 to 38 Variants 39 to 50 Variants 51 to 62 Variant 63 Variants 64 to 75 Variants 76 to 87 Variants 88 to 91		30 190 25 185 25 20 25 185 25 20	°C/W

NOTES

1. Pulsed measurement, pulse width = 4.0μ s, p.r.f. = 1.0kHz.

TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - A.C. PARAMETERS

No.	CHARACTERISTICS	SYMBOL	MIL-STD-750	TEST	TEST	LIMITS		UNIT
INO.	CHARACTERISTICS	STIVIDUL	TEST METHOD	FIG.	CONDITIONS	MIN.	MIN. MAX.	
5	Total Capacitance	C _T	4001	-	V _R = -50V f = 1.0MHz	Not	e 1	pF
6	Minority Carrier Lifetime	Ն _	-	4(a)	I _F = 4.5mA Variants 01 to 13 Variants 14 to 26 Variants 27 to 63 Variants 64 to 75 Variants 76 to 91	- - - -	1.5 2.3 3.0 4.5 6.0	μѕ
7	Forward Slope Resistance	R _{FS}	<u>-</u>	4(b)	I_F = 40mA f_o = 500MHz Variants 01 to 13 Variants 14 to 26 Variants 27 to 38 Variants 39 to 50 Variants 51 to 63 Variants 64 to 75 Variants 76 to 87 Variants 88 to 91	- - - - - -	1.3 1.0 0.8 0.7 1.3 1.0 0.8 0.7	Ω

NOTES

1. See Column 4 of Table 1(a).



PAGE 25

ISSUE 1

TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No	No. CHARACTERISTICS S	SVMBOL	SPEC.AND/OR	TEST CONDITIONS	LIMITS		LINUT
INO.		STWIDOL	TEST METHOD	TEST CONDITIONS	MIN.	MAX.	UNIT
2	Reverse Current 2	I _{R2}	As per Table 2	As per Table 2	-	10	μА

TABLE 4 - PARAMETER DRIFT VALUES

No.	CHARACTERISTICS	SYMBOL	SPEC.AND/OR TEST METHOD	TEST CONDITIONS	CHANGE LIMITS (Δ)	UNIT
2	Reverse Current 2	I _{R2}	As per Table 2	As per Table 2 Variants 01 to 50	± 10 (1) or (2) ± 100 (1)	nA %
				Variants 51 to 91	± 10 (1) or (2) ± 100 (1)	μA %
3	Forward Voltage	·V _F	As per Table 2	As per Table 2	± 100 (1)	mV

NOTES

- 1. $\Delta 1 = \Delta 2 = \Delta 3$.
- 2. Whichever is the greater, referred to the initial measurement.



PAGE 26

ISSUE '

FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

FIGURE 4(a) - MINORITY CARRIER LIFETIME

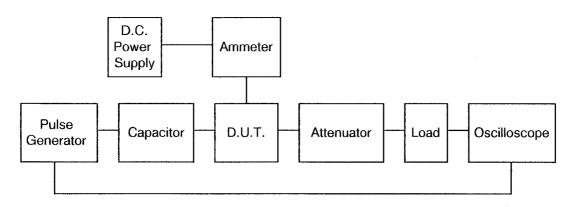
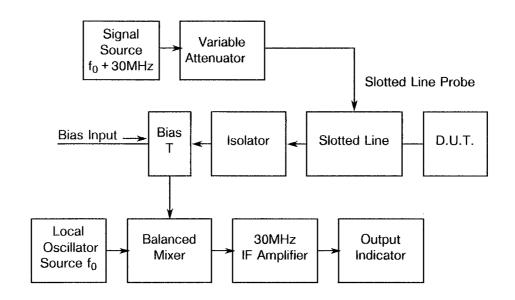


FIGURE 4(b) - FORWARD SLOPE RESISTANCE





PAGE 27

ISSUE 1

TABLE 5(a) - CONDITIONS FOR HIGH TEMPERATURE REVERSE BIAS BURN-IN

No.	CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT
1	Ambient Temperature	T _{amb}	+ 150(+ 0 - 3)	°C
2	Reverse Voltage	V _R	Variants 01 to 50: -150 Variants 51 to 91: -200	V

TABLE 5(b) - CONDITIONS FOR POWER BURN-IN

No.	CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT
1	Ambient Temperature	T _{amb}	+ 125(+ 0 - 3)	°C
2	Forward Current	lF	Variants 01 to 50: -100 Variants 51 to 91: -125	mA

TABLE 5(c) - CONDITIONS FOR OPERATING LIFE TESTS

No.	CHARACTERISTICS	SYMBOL	CONDITIONS	UNIT
1	Ambient Temperature 1	T _{amb1}	+ 115(+ 0 - 3)	°C
2	Forward Current 1	l _{F1}	Variants 01 to 50: -100 Variants 51 to 91: -125	mA
3	Ambient Temperature 2	T _{amb2}	+ 125(+ 0 - 3)	°C
4	Forward Current 2	· I _{F2}	Variants 01 to 50: -100 Variants 51 to 91: -125	mA

FIGURE 5(a) - ELECTRICAL CIRCUIT FOR HIGH TEMPERATURE REVERSE BIAS BURN-IN

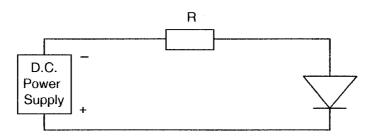
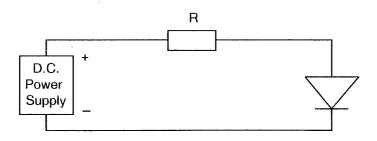


FIGURE 5(b) - ELECTRICAL CIRCUIT FOR POWER BURN-IN AND OPERATING LIFE TESTS





PAGE 28

ISSUE 1

4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC SPECIFICATION NO. 5010)</u>

4.8.1 Electrical Measurements on Completion of Environmental Tests

The parameters to be measured on completion of environmental tests are scheduled in Table 2. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.2 <u>Electrical Measurements at Intermediate Points and on Completion of Endurance Tests</u>

The parameters to be measured at intermediate points and on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ±3 °C.

4.8.3 Conditions for Operating Life Tests (Part of Endurance Testing)

The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 5010. The conditions for operating life testing are specified in Table 5(c) of this specification.

4.8.4 Electrical Circuits for Operating Life Tests

The circuit to be used for performance of the operating life test shall be the same as shown in Figure 5(b) for Power Burn-in.

4.9 TOTAL DOSE IRRADIATION TESTING

4.9.1 Application

If specified in Para. 4.2.1 of this specification, total dose irradiation testing shall be performed in accordance with the requirements of ESA/SCC Basic Specification No. 22900.

4.9.2 Bias Conditions

Continuous bias shall be applied during irradiation testing as shown in Figure 6 of this specification.

4.9.3 Electrical Measurements

The parameters to be measured prior to irradiation exposure are scheduled in Table 2 of this specification. Only devices which meet the requirements of Table 2 shall be included in the test sample.

The parameters to be measured during and on completion of irradiation testing are scheduled in Table 7 of this specification.

4.10 SPECIAL TESTING

Not applicable.



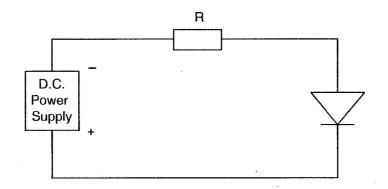
PAGE 29

ISSUE 1

TABLE 6 - ELECTRICAL MEASUREMENTS AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

Na	I NO TOUNDACTEDISTICS ISOMBOLI	CVMPOL	SPEC. AND/OR	TEST CONDITIONS	LIM	11807	
INO.		TEST METHOD	TEST CONDITIONS	MIN.	MAX.	UNIT	
1	Reverse Current 1	l _{R1}	As per Table 2	As per Table 2	As per	Table 2	μА
2	Reverse Current 2	I _{R2}	As per Table 2	As per Table 2	As per	Table 2	nA
3	Forward Voltage	V _F	As per Table 2	As per Table 2	As per	Table 2	V
5	Total Capacitance	C _T	As per Table 2	As per Table 2	As per	Table 2	ρF
7	Forward Slope Resistance	R _{FS}	As per Table 2	As per Table 2	As per	Table 2	Ω

FIGURE 6 - BIAS CONDITIONS FOR IRRADIATION TESTING



NOTES

1. A reverse bias of $V_R = -150V$ (Variants 01 to 50) or -200V (Variants 51 to 91) shall be applied.



PAGE 30

ISSUE 1

TABLE 7 - ELECTRICAL MEASUREMENTS DURING AND ON COMPLETION OF IRRADIATION TESTING

No.	CHARACTERISTICS	SYMBOL	SPEC. AND/OR TEST METHOD	TEST CONDITIONS	CHANGE LIMITS (Δ)	UNIT
6	Minority Carrier Lifetime	Շլ_	As per Table 2	As per Table 2	Note 1	%

NOTES

1. The graph given below shall be used to determine the maximum permitted change.

